



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

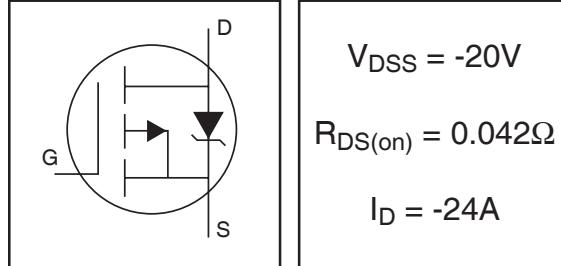
Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

IRL5602SPbF

HEXFET® Power MOSFET

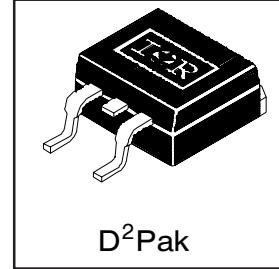
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- P-Channel
- Fast Switching
- Fully Avalanche Rated
- Lead-Free



Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.



Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -4.5V$	-24	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ -4.5V$	-17	
I_{DM}	Pulsed Drain Current ①	-96	
$P_D @ T_C = 25^\circ C$	Power Dissipation	75	W
	Linear Derating Factor	0.5	W/ [°] C
V_{GS}	Gate-to-Source Voltage	± 8.0	V
E_{AS}	Single Pulse Avalanche Energy ②	290	mJ
I_{AR}	Avalanche Current ①	-12	A
E_{AR}	Repetitive Avalanche Energy ①	7.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-0.81	V/ns
T_J	Operating Junction and	-55 to + 175	[°] C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
R_{0JC}	Junction-to-Case	—	2.0	[°] C/W
R_{0JA}	Junction-to-Ambient (PCB Mounted,steady-state)**	—	40	

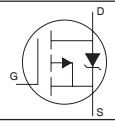
IRL5602SPbF

International
Rectifier

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-20	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	-0.013	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = -1\text{mA}$ ⑤
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.042	Ω	$V_{\text{GS}} = -4.5\text{V}$, $I_D = -12\text{A}$ ④
		—	—	0.062		$V_{\text{GS}} = -2.7\text{V}$, $I_D = -10\text{A}$ ④
		—	—	0.075		$V_{\text{GS}} = -2.5\text{V}$, $I_D = -10\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	-0.7	—	-1.0	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = -250\mu\text{A}$
g_{fs}	Forward Transconductance	12	—	—	S	$V_{\text{DS}} = -15\text{V}$, $I_D = -12\text{A}$ ⑤
I_{DSS}	Drain-to-Source Leakage Current	—	—	-25	μA	$V_{\text{DS}} = -20\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	-250		$V_{\text{DS}} = -16\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	500	nA	$V_{\text{GS}} = -8.0\text{V}$
	Gate-to-Source Reverse Leakage	—	—	500		$V_{\text{GS}} = 8.0\text{V}$
Q_g	Total Gate Charge	—	—	44	nC	$I_D = -12\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	8.7		$V_{\text{DS}} = -16\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	19		$V_{\text{GS}} = -4.5\text{V}$, See Fig. 6 and 13 ④ ⑤
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	9.7	—	ns	$V_{\text{DD}} = -10\text{V}$
t_r	Rise Time	—	73	—		$I_D = -12\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	53	—		$R_G = 6.0\Omega$, $V_{\text{GS}} = 4.5\text{V}$
t_f	Fall Time	—	84	—		$R_D = 0.8\Omega$, See Fig. 10 ④ ⑤
L_s	Internal Source Inductance	—	7.5	—	nH	Between lead, and center of die contact
C_{iss}	Input Capacitance	—	1460	—	pF	$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	790	—		$V_{\text{DS}} = -15\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	370	—		$f = 1.0\text{MHz}$, See Fig. 5 ⑤

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-24	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-96		
V_{SD}	Diode Forward Voltage	—	—	-1.4	V	$T_J = 25^\circ\text{C}$, $I_S = -12\text{A}$, $V_{\text{GS}} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	58	88	ns	$T_J = 25^\circ\text{C}$, $I_F = -12\text{A}$
Q_{rr}	Reverse Recovery Charge	—	54	81	nC	$dI/dt = -100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_s+L_D)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25^\circ\text{C}$, $L = 3.0\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = -14\text{A}$. (See Figure 12)
- * When mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.

③ $I_{SD} \leq -12\text{A}$, $di/dt \leq 120\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$,
 $T_J \leq 175^\circ\text{C}$

④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

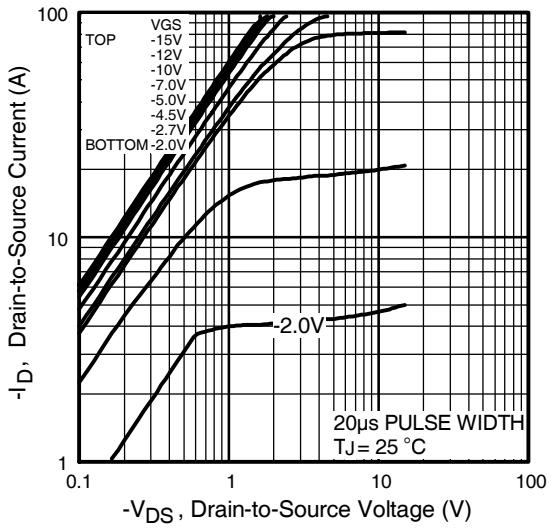


Fig 1. Typical Output Characteristics

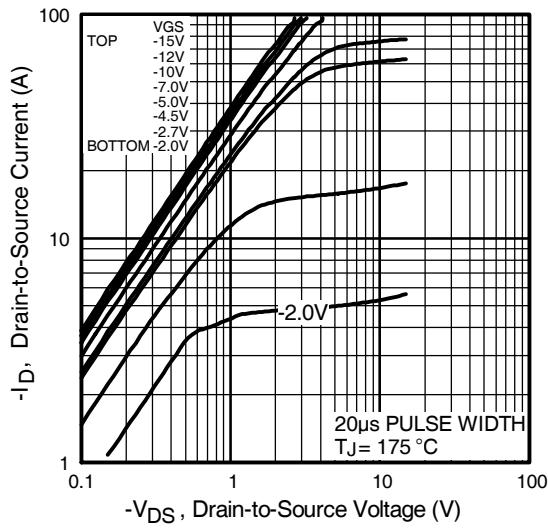


Fig 2. Typical Output Characteristics

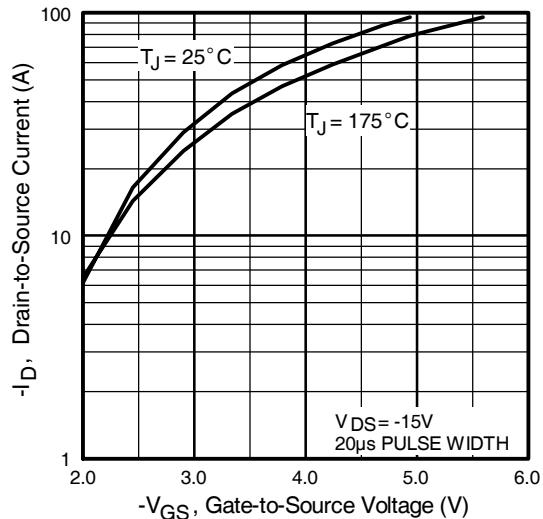


Fig 3. Typical Transfer Characteristics

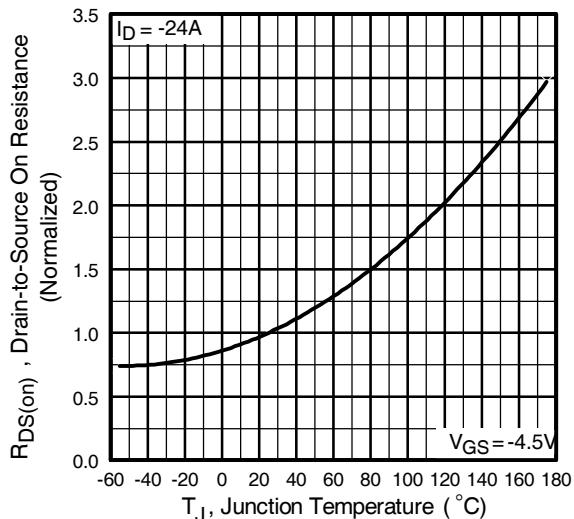


Fig 4. Normalized On-Resistance
Vs. Temperature

IRL5602SPbF

International
Rectifier

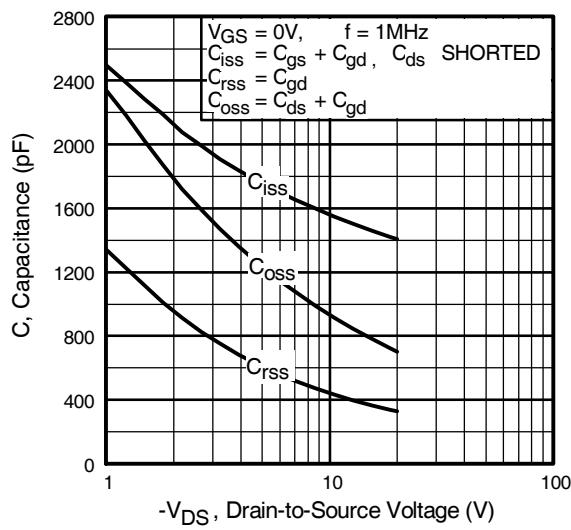


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

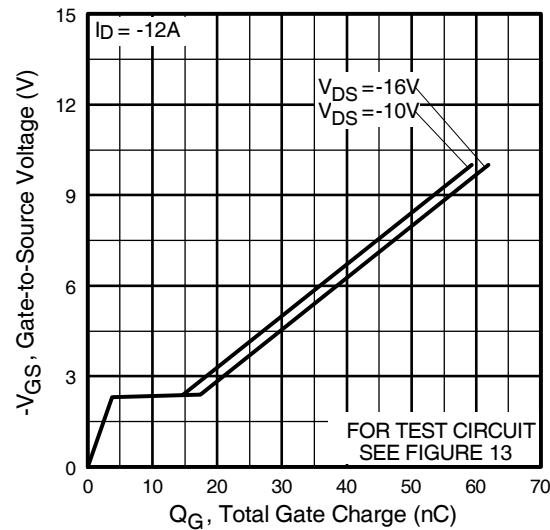


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

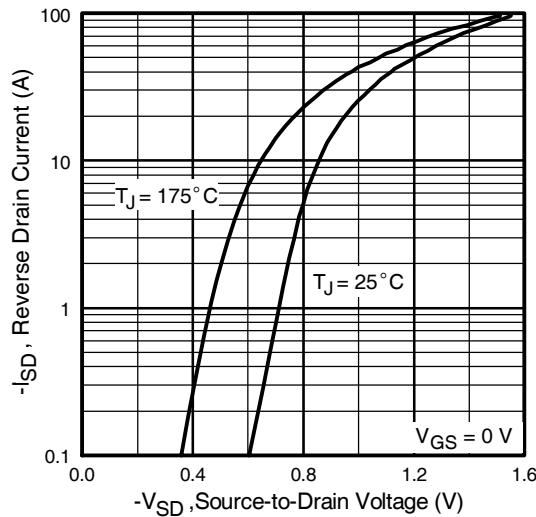


Fig 7. Typical Source-Drain Diode
Forward Voltage

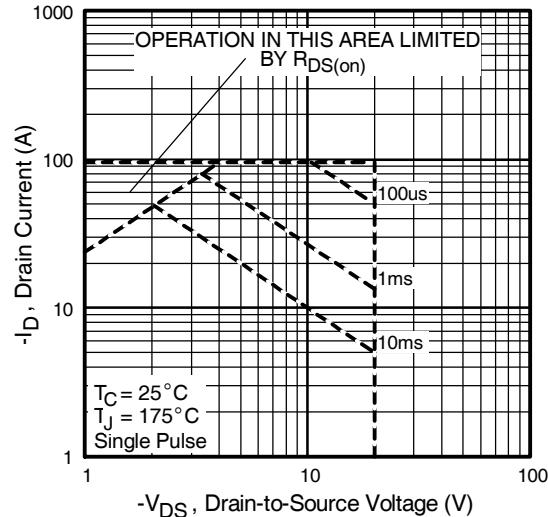


Fig 8. Maximum Safe Operating Area

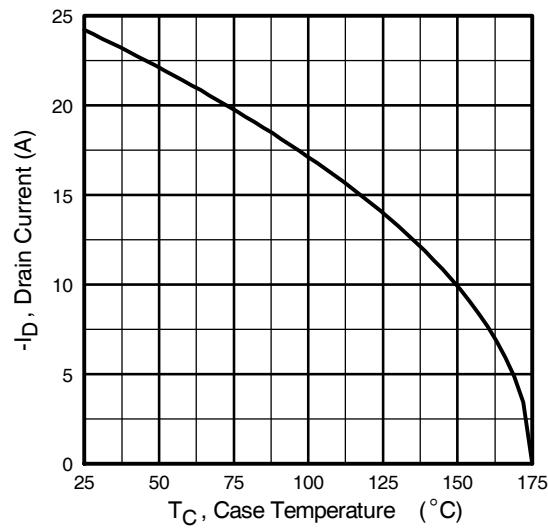


Fig 9. Maximum Drain Current Vs.
Case Temperature

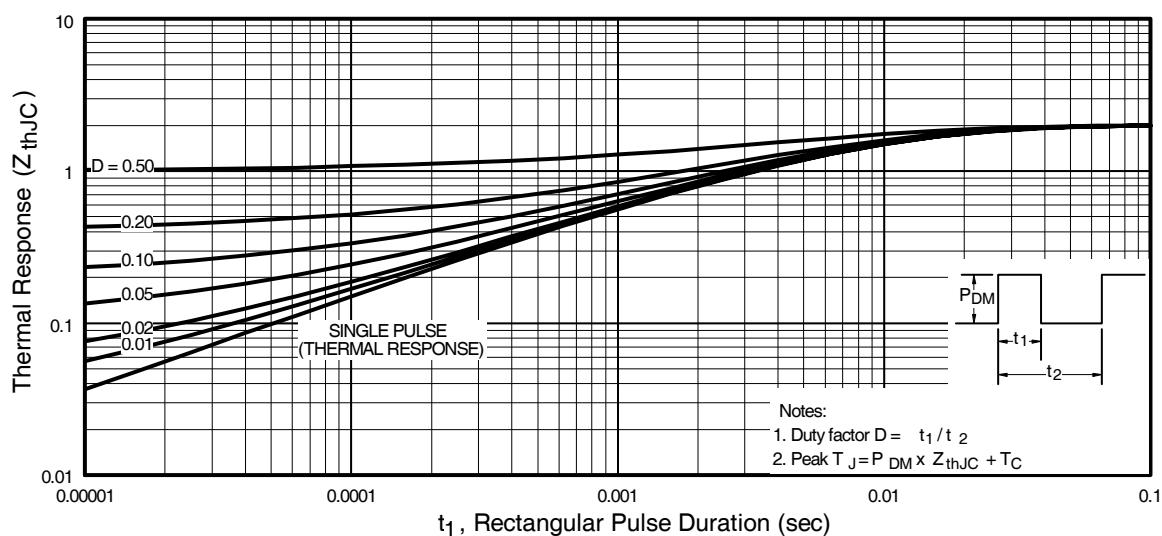
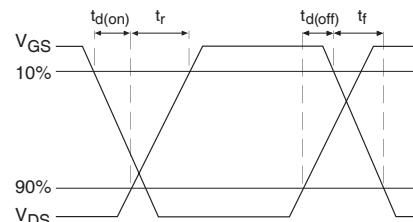
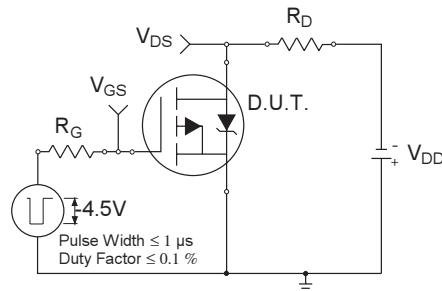


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

IRL5602SPbF

International
IR Rectifier

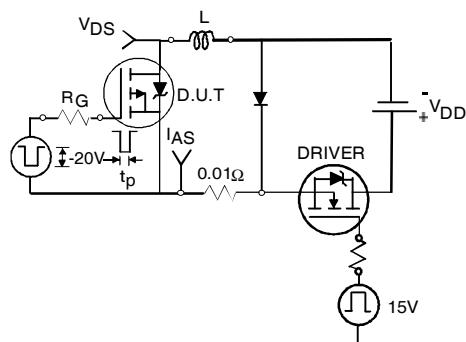


Fig 12a. Unclamped Inductive Test Circuit

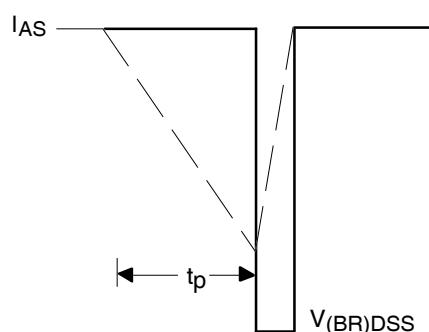


Fig 12b. Unclamped Inductive Waveforms

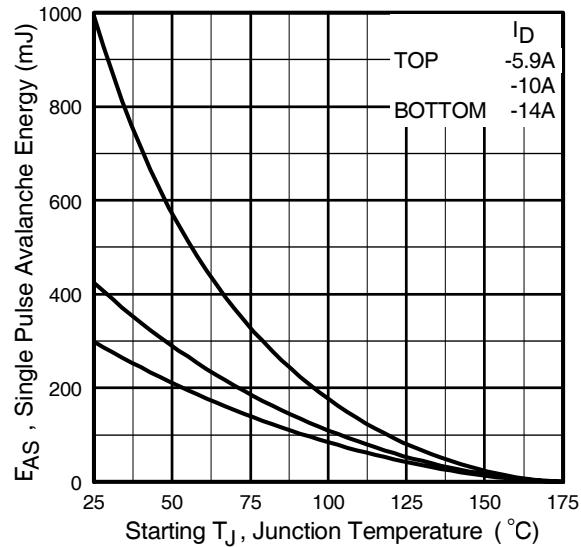


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

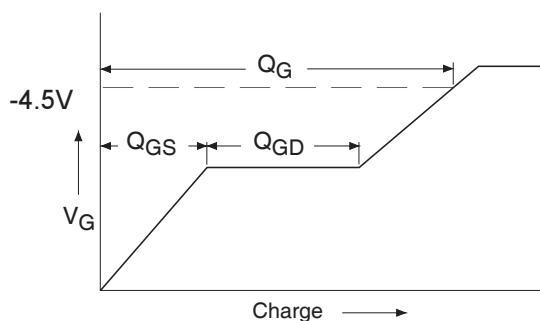


Fig 13a. Basic Gate Charge Waveform

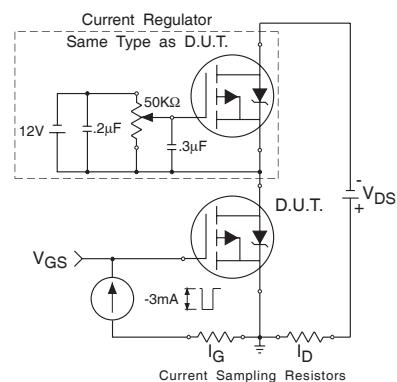
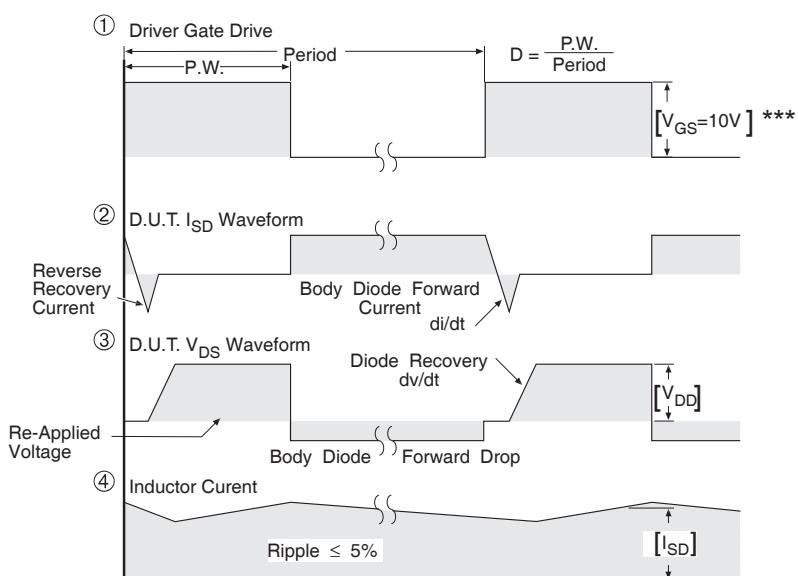
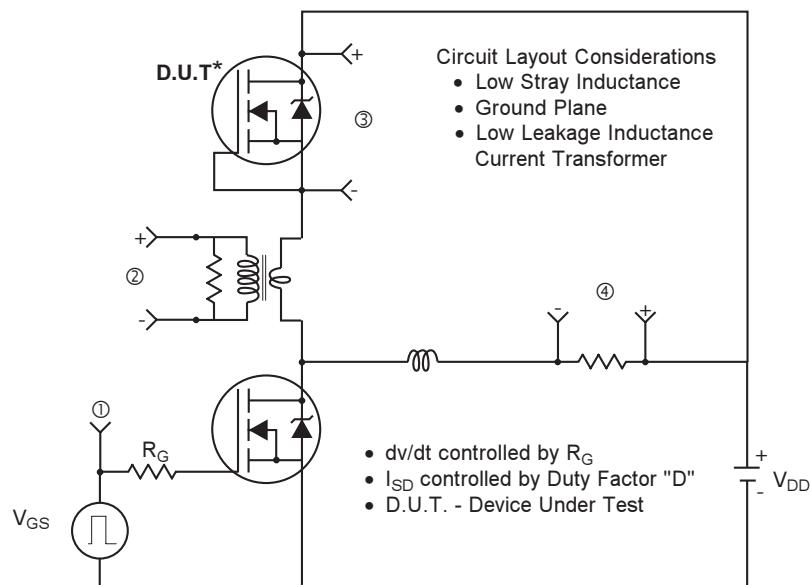


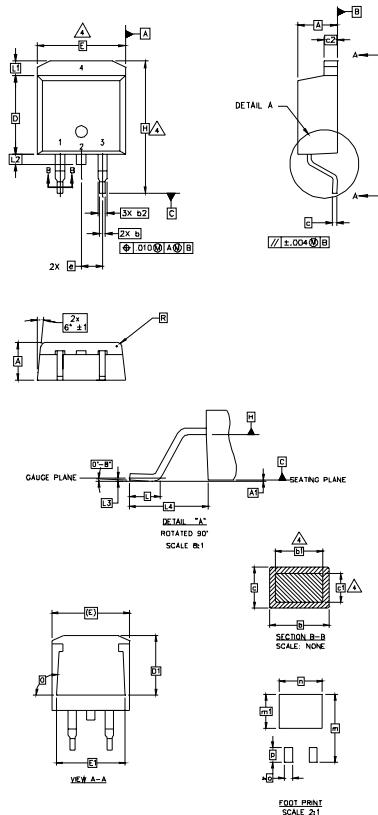
Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

D²Pak Package Outline

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

\triangle DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.

5. CONTROLLING DIMENSION: INCH.

SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035	4	
b2	1.14	1.78	.045	.070		
c	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	4	
c2	1.14	1.65	.045	.065		
D	8.51	9.65	.335	.380	3	
D1	6.86		.270			
E	9.65	10.67	.380	.420	3	
E1	6.22		.245			
e	2.54	BSC	.100	BSC		
H	14.61	15.88	.575	.625		
L	1.78	2.79	.070	.110		
L1		1.65		.065		
L2	1.27	1.78	.050	.070		
L3	0.25	BSC	.010	BSC		
L4	4.78	5.28	.188	.208		
m	17.78		.700			
m1	8.89		.350			
n	11.43		.450			
o	2.08		.082			
p	3.81		.150			
R	0.51	0.71	.020	.028		
θ	90°	93°	.90°	.93°		

LEAD ASSIGNMENTS

HEXFET

1. GATE
- 2, 4. DRAIN
3. SOURCE

IGBTs, CoPACK

1. GATE
- 2, 4. COLLECTOR
3. Emitter

DIODES

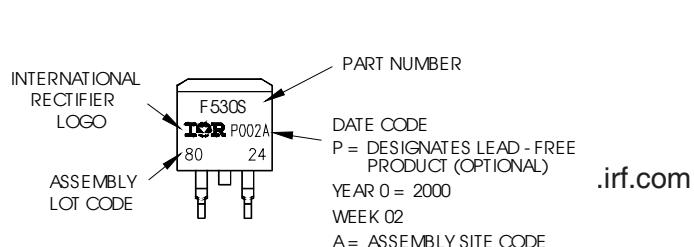
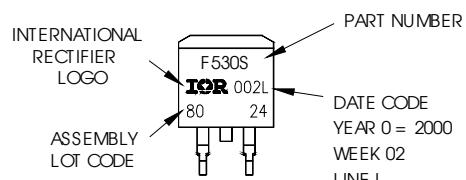
1. ANODE *
- 2, 4. CATHODE
3. ANODE

* PART DEPENDENT.

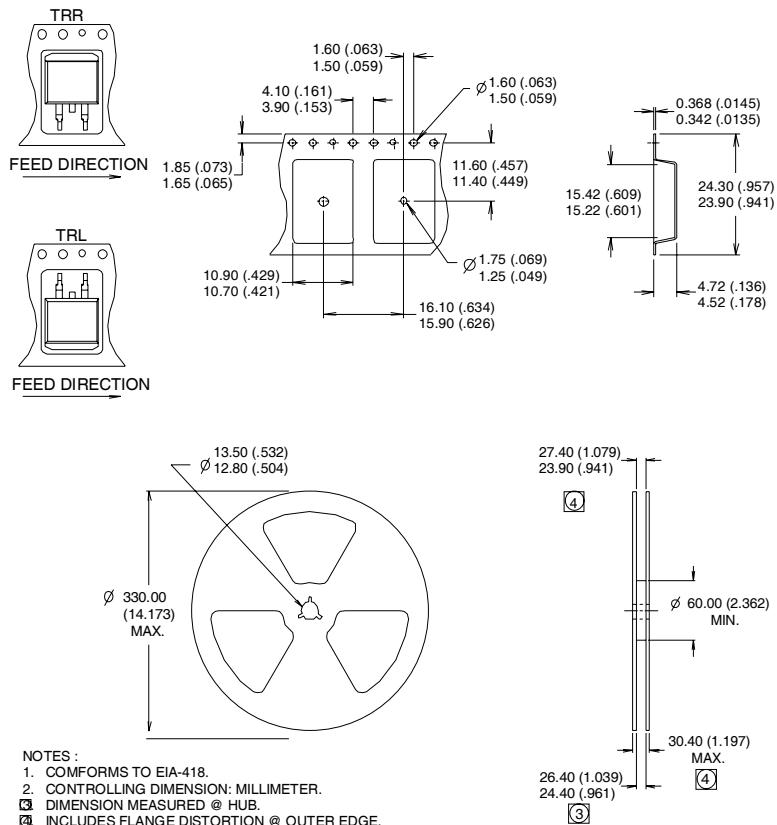
D²Pak Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH
LOT CODE 8024
ASSEMBLED ON WW02, 2000
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position
indicates "Lead - Free"



D²Pak Tape & Reel Information



Data and specifications subject to change without notice.

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
 TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.04/05

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>